IP4774CZ14

VGA interface with integrated h-sync buffer, ESD protection and termination resistor

Rev. 01 — 24 February 2009 Objective data sheet

1. General description

The IP4774CZ14 is a VGA or DVI-I interface intended for connection between a video transmitter such as a PC graphics card and a VGA or DVI-I receiver, such as a PC monitor. The IP4774CZ14 has ESD protection for the DDC lines, ESD protection plus buffering for the h-sync line, and high-level ESD protection diodes for the RGB video signal lines.

The h-sync signal is buffered by a non-inverting buffer which can accept TTL-level input. The buffer convert TTL-level input to CMOS-level output which swings between $V_{CC(SYNC)}$ and GND.

An external termination resistor can be added to achieve the desired termination, which is typically required for the h-sync line of the video interface.

The IP4774CZ14 has a typical output resistance (R_O) of 10 Ω.

2. Features

- Integrated high-level ESD protection, buffering, sync-signal impedance matching
- All pin connections have integrated rail-to-rail clamping diodes providing downstream ESD protection of ±8 kV according to IEC 61000-4-2, level 4
- Driver for h-sync line
- Line capacitance < 4 pF per channel

3. Applications

Buffer and terminating channels, reduce EMI/RFI and provide downstream ESD protection for:

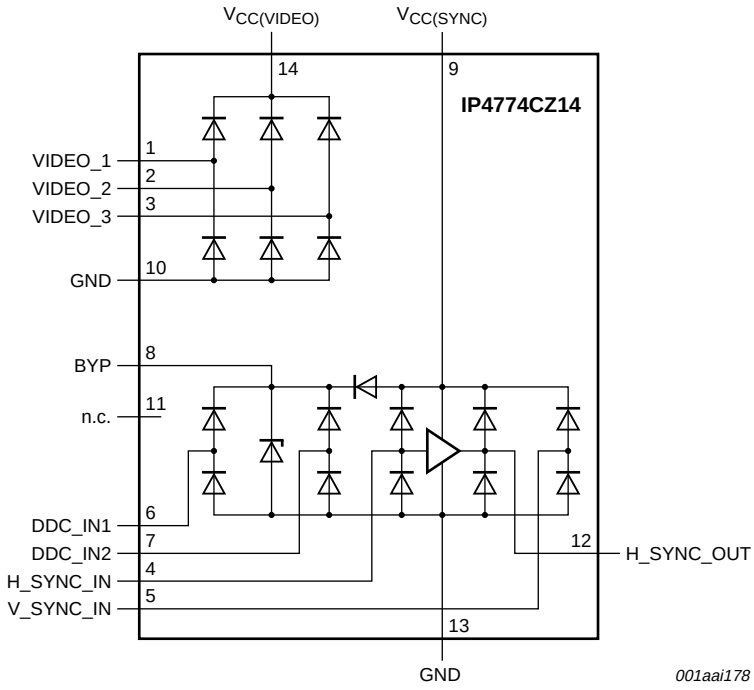
- VGA interfaces including DDC channels
- Desktop and notebook PCs, LCD TVs and PC monitors
- Graphics cards
- Set-top boxes
- Game consoles
- DVD players

4. Ordering information

Table 1. Ordering information

Type number	Package		
	Name	Description	Version
IP4774CZ14	SSOP14	plastic shrink small outline package; 14 leads; body width 5.3 mm	SOT337-1

5. Functional diagram



The ESD structure of the IP4774CZ14 enables a receiver and a transmitter application.

Fig 1. Functional diagram

6. Pinning information

6.1 Pinning

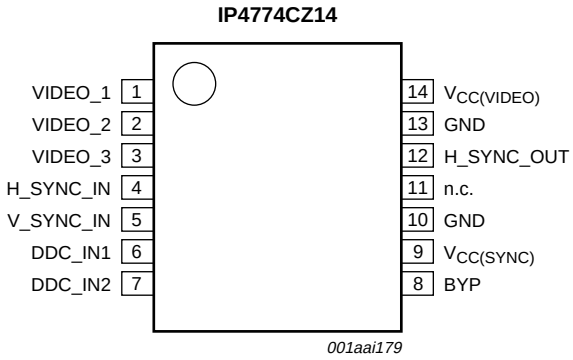


Fig 2. Pinning configuration

6.2 Pin description

Table 2. Pin description

Symbol	Pin	Description
VIDEO_1	1	ESD protection for video channel 1
VIDEO_2	2	ESD protection for video channel 2
VIDEO_3	3	ESD protection for video channel 3
H_SYNC_IN	4	h-sync signal input
V_SYNC_IN	5	h-sync protection input
DDC_IN1	6	DDC signal input
DDC_IN2	7	DDC signal input
BYP	8	for connecting a 100 nF bypass capacitor to increase ESD clamping performance for the DDC outputs
$V_{CC(SYNC)}$	9	supply voltage for sync buffer
GND	10	ground
n.c.	11	not connected
H_SYNC_OUT	12	h-sync signal output
GND	13	ground
$V_{CC(VIDEO)}$	14	supply voltage for video protection circuit

7. Limiting values

Table 3. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Max	Unit
$V_{CC(VIDEO)}$	video supply voltage			GND – 0.5	5.5	V
$V_{CC(SYNC)}$	synchronization supply voltage			3.0	5.5	V
V_I	input voltage	pins VIDEO_1, VIDEO_2, VIDEO_3		GND – 0.5	$V_{CC(VIDEO)}$	V
		pins H_SYNC_IN, V_SYNC_IN, DDC_IN1, DDC_IN2		GND – 0.5	$V_{CC(SYNC)}$	V
V_{ESD}	electrostatic discharge voltage	IEC 61000-4-2, level 4, contact	[1]	–8	+8	kV
P_{tot}	total power dissipation	T_{amb} = 25 °C; f_{sync} = 100 kHz; C_L = 6 nF; R_L = 10 kΩ		-	50	mW
T_{stg}	storage temperature			–55	+125	°C

[1] Pins BYP, $V_{CC(VIDEO)}$ and $V_{CC(SYNC)}$ must be bypassed to pin GND via a low impedance ground plane with 100 nF.

8. Characteristics

Table 4. Characteristics

T_{amb} = 25 °C unless otherwise specified.

Symbol	Parameter	Conditions		Min	Typ	Max	Unit
Analog video (RGB)							
$I_{CC(VIDEO)}$	supply current on pin $V_{CC(VIDEO)}$	$V_{CC(VIDEO)}$ = 5.0 V; static input signals		-	-	10	µA
C_{ch}	channel capacitance	$V_{CC(VIDEO)}$ = 5.0 V; f = 1 MHz; V_I = 2.5 V (p-p); V_{bias} = 2.5 V	[1]	-	-	4	pF
I_I	input current	$V_{CC(VIDEO)}$ = 5.0 V; V_I = $V_{CC(VIDEO)}$ or GND		-	-	±1	µA
V_{Fd}	diode forward voltage	I_F = 1 mA		-	0.7	-	V
DDC							
C_{ch}	channel capacitance	f = 1 MHz; V_I = 2.5 V (p-p); V_{bias} = 2.5 V	[1]	-	-	4	pF
I_I	input current	V_I = 5.0 V		-	-	±1	µA
V_{Fd}	diode forward voltage	I_F = 1 mA		-	0.7	-	V
H-sync buffer							
$V_{CC(SYNC)}$	synchronization supply voltage			3.0	5.0	5.5	V
$I_{CC(SYNC)}$	supply current on pin $V_{CC(SYNC)}$	$V_{CC(SYNC)}$ = 5.0 V; static input signals	[2]	-	-	10	µA
C_{ch}	channel capacitance	$V_{CC(SYNC)}$ = 5.0 V; f = 1 MHz; V_I = 1.65 V	[1]	-	-	4	pF
I_I	input current	$V_{CC(SYNC)}$ = 5.0 V; V_I = 2.5 V (p-p); V_{bias} = 2.5 V	[1]	-	-	±1	µA
V_{Fd}	diode forward voltage	I_F = 1 mA		-	0.7	-	V
V_{IH}	HIGH-level input voltage	$V_{CC(SYNC)}$ = 5.0 V	[3]	2.0	-	-	V
V_{IL}	LOW-level input voltage	$V_{CC(SYNC)}$ = 5.0 V	[3]	-	-	0.6	V
V_{OH}	HIGH-level output voltage	$V_{CC(SYNC)}$ = 5.0 V; I_{OH} = 24 mA	[3]	2.0	-		V
V_{OL}	LOW-level output voltage	$V_{CC(SYNC)}$ = 5.0 V; I_{OL} = 24 mA	[3]	-	-	0.8	V
R_O	output resistance		[3]	-	10	-	Ω
t_{PLH}	LOW to HIGH propagation delay	$V_{CC(SYNC)}$ = 5.0 V; C_L = 50 pF; $t_{r(i)}$ and $t_{f(i)}$ ≤ 5 ns	[1]	-	-	12	ns

Table 4. Characteristics *...continued*

T_{amb} = 25 °C unless otherwise specified.

Symbol	Parameter	Conditions		Min	Typ	Max	Unit
t_{PHL}	HIGH to LOW propagation delay	$V_{CC(SYNC)}$ = 5.0 V; C_L = 50 pF; $t_{r(i)}$ and $t_{f(i)}$ ≤ 5 ns	[1]	-		12	ns
$t_{r(o)}$	output rise time	$V_{CC(SYNC)}$ = 5.0 V; C_L = 50 pF; $t_{r(i)}$ and $t_{f(i)}$ ≤ 5 ns		-	4	-	ns
$t_{f(o)}$	output fall time	$V_{CC(SYNC)}$ = 5.0 V; C_L = 50 pF; $t_{r(i)}$ and $t_{f(i)}$ ≤ 5 ns		-	4	-	ns

[1] Guaranteed by design and characterization.

[2] H-sync output unloaded.

[3] These parameters apply only to the sync buffer; note that $R_O = R_{buffer}$.

9. Application information

The IP4774CZ14 should be placed as close as possible to the VGA or DVI-I interface connector. The ESD-protected channels on pins VIDEO_1, VIDEO_2 and VIDEO_3 can be connected in any order with RGB signals. The h-sync buffer is needed to have a low jitter for the sampling PLL.

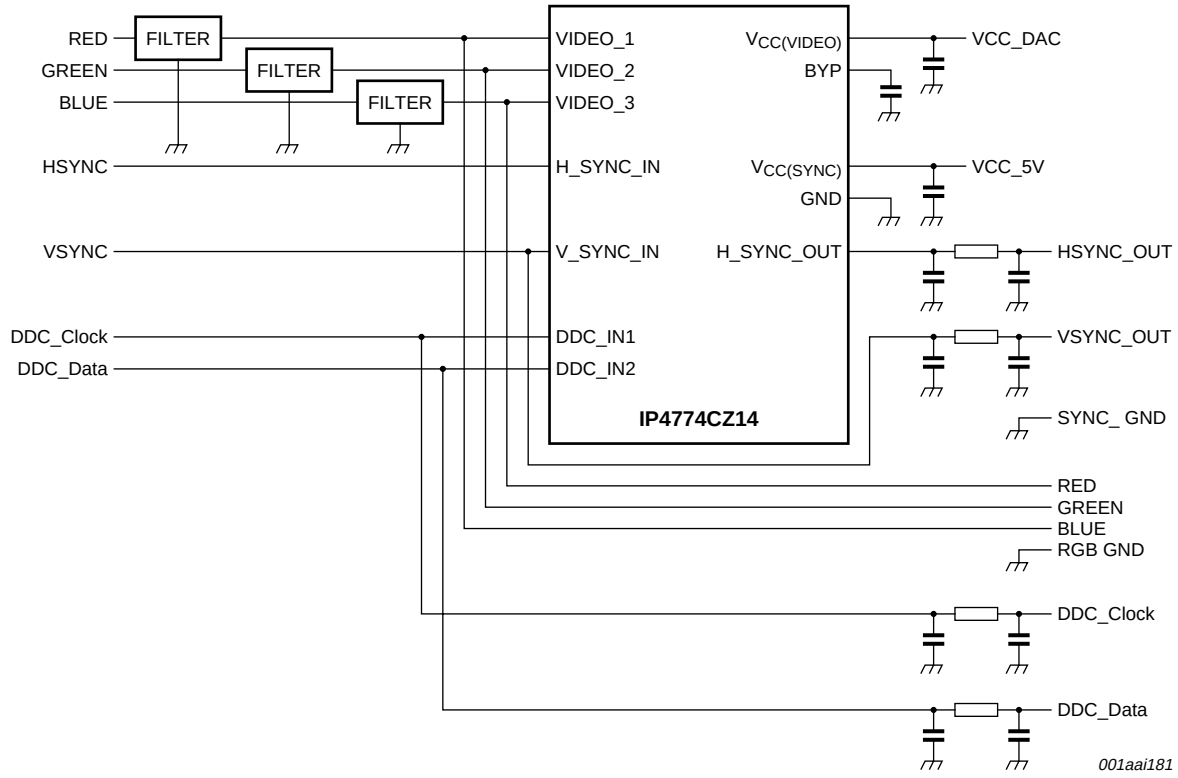


Fig 3. Application diagram (transmitter)

The IP4774CZ14 is connected to the input lines of the VGA connector to protect the VGA port including all signals and buffering of the h-sync signal.

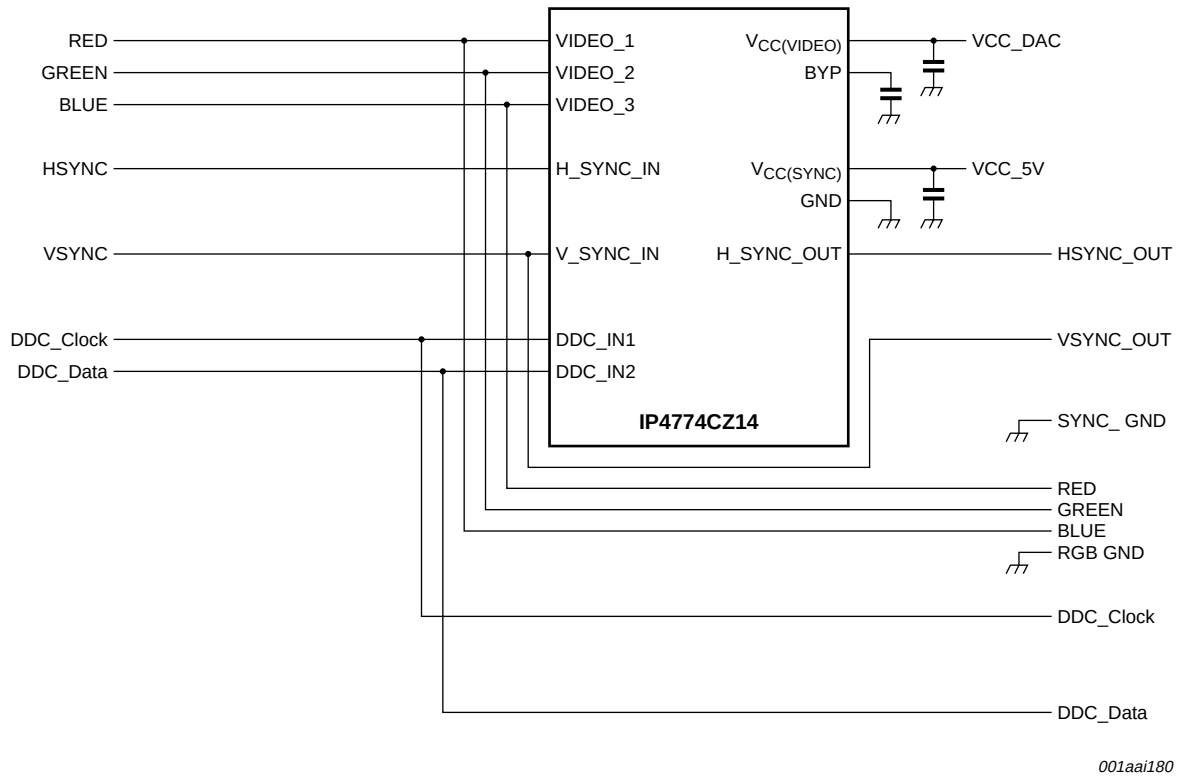
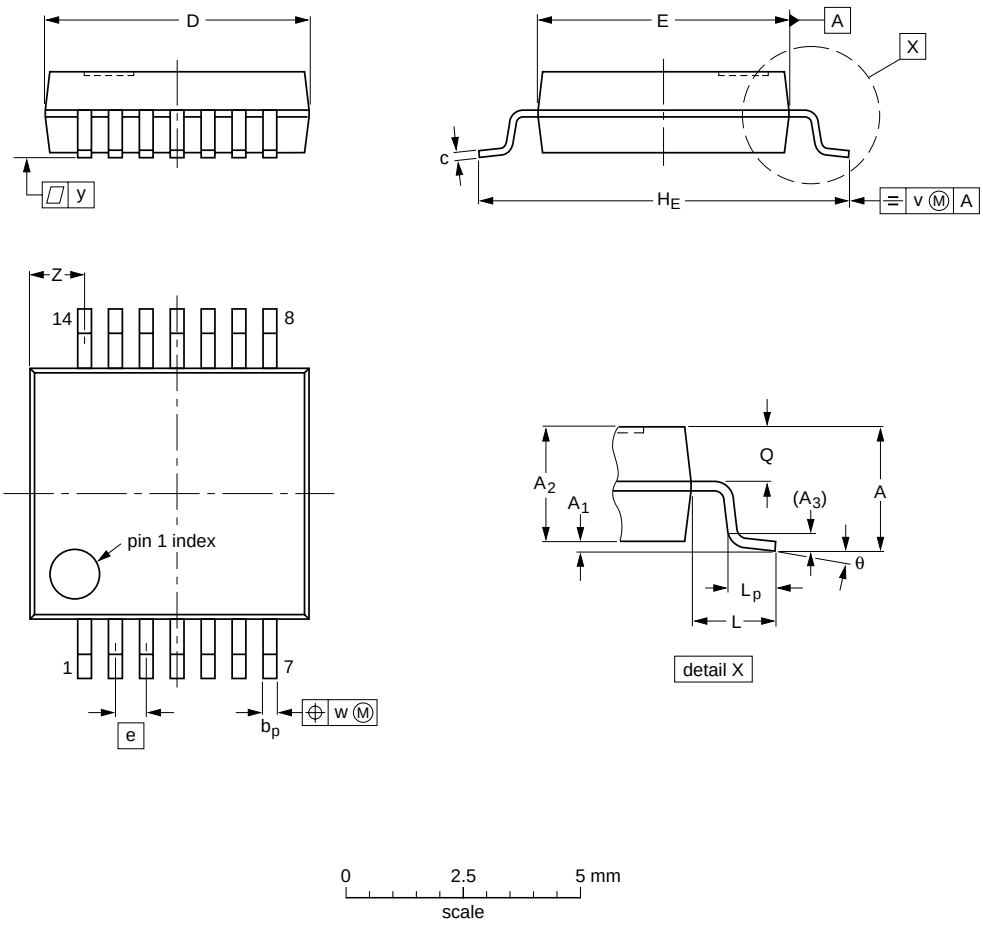


Fig 4. Application diagram (receiver)

10. Package outline

SSOP14: plastic shrink small outline package; 14 leads; body width 5.3 mm **SOT337-1**



DIMENSIONS (mm are the original dimensions)

UNIT	A max.	A_1	A_2	A_3	b_p	c	D (1)	E (1)	e	H_E	L	L_p	Q	v	w	y	Z (1)	θ
mm	2	0.21 0.05	1.80 1.65	0.25	0.38 0.25	0.20 0.09	6.4 6.0	5.4 5.2	0.65	7.9 7.6	1.25	1.03 0.63	0.9 0.7	0.2	0.13	0.1	1.4 0.9	8^o 0^o

Note

1. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	JEITA			
SOT337-1		MO-150				~~99-12-27~~ 03-02-19

Fig 5. Package outline SOT337-1 (SSOP14)

11. Soldering of SMD packages

This text provides a very brief insight into a complex technology. A more in-depth account of soldering ICs can be found in Application Note *AN10365 "Surface mount reflow soldering description"*.

11.1 Introduction to soldering

Soldering is one of the most common methods through which packages are attached to Printed Circuit Boards (PCBs), to form electrical circuits. The soldered joint provides both the mechanical and the electrical connection. There is no single soldering method that is ideal for all IC packages. Wave soldering is often preferred when through-hole and Surface Mount Devices (SMDs) are mixed on one printed wiring board; however, it is not suitable for fine pitch SMDs. Reflow soldering is ideal for the small pitches and high densities that come with increased miniaturization.

11.2 Wave and reflow soldering

Wave soldering is a joining technology in which the joints are made by solder coming from a standing wave of liquid solder. The wave soldering process is suitable for the following:

- Through-hole components
- Leaded or leadless SMDs, which are glued to the surface of the printed circuit board

Not all SMDs can be wave soldered. Packages with solder balls, and some leadless packages which have solder lands underneath the body, cannot be wave soldered. Also, leaded SMDs with leads having a pitch smaller than ~0.6 mm cannot be wave soldered, due to an increased probability of bridging.

The reflow soldering process involves applying solder paste to a board, followed by component placement and exposure to a temperature profile. Leaded packages, packages with solder balls, and leadless packages are all reflow solderable.

Key characteristics in both wave and reflow soldering are:

- Board specifications, including the board finish, solder masks and vias
- Package footprints, including solder thieves and orientation
- The moisture sensitivity level of the packages
- Package placement
- Inspection and repair
- Lead-free soldering versus SnPb soldering

11.3 Wave soldering

Key characteristics in wave soldering are:

- Process issues, such as application of adhesive and flux, clinching of leads, board transport, the solder wave parameters, and the time during which components are exposed to the wave
- Solder bath specifications, including temperature and impurities

11.4 Reflow soldering

Key characteristics in reflow soldering are:

- Lead-free versus SnPb soldering; note that a lead-free reflow process usually leads to higher minimum peak temperatures (see Figure 6) than a SnPb process, thus reducing the process window
- Solder paste printing issues including smearing, release, and adjusting the process window for a mix of large and small components on one board
- Reflow temperature profile; this profile includes preheat, reflow (in which the board is heated to the peak temperature) and cooling down. It is imperative that the peak temperature is high enough for the solder to make reliable solder joints (a solder paste characteristic). In addition, the peak temperature must be low enough that the packages and/or boards are not damaged. The peak temperature of the package depends on package thickness and volume and is classified in accordance with Table 5 and 6

Table 5. SnPb eutectic process (from J-STD-020C)

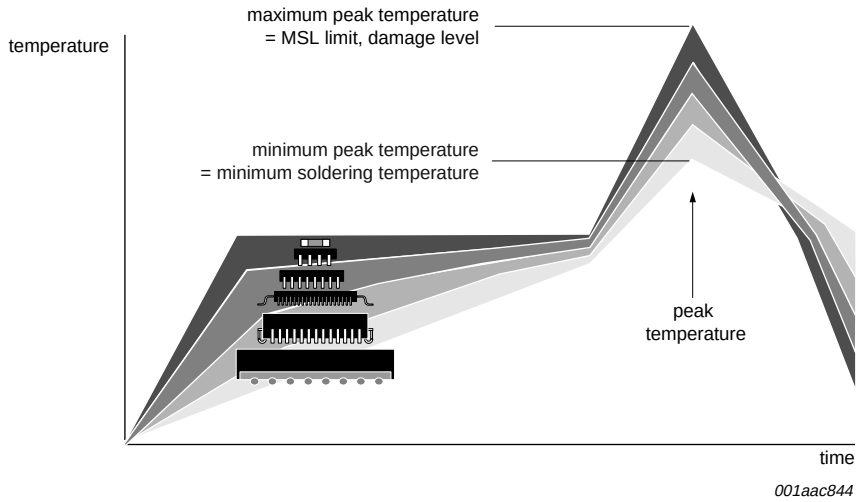
Package thickness (mm)	Package reflow temperature (°C)	
	Volume (mm^3)	
	< 350	≥ 350
< 2.5	235	220
≥ 2.5	220	220

Table 6. Lead-free process (from J-STD-020C)

Package thickness (mm)	Package reflow temperature (°C)		
	Volume (mm^3)		
	< 350	350 to 2000	> 2000
< 1.6	260	260	260
1.6 to 2.5	260	250	245
> 2.5	250	245	245

Moisture sensitivity precautions, as indicated on the packing, must be respected at all times.

Studies have shown that small packages reach higher temperatures during reflow soldering, see Figure 6.



MSL: Moisture Sensitivity Level

Fig 6. Temperature profiles for large and small components

For further information on temperature profiles, refer to Application Note *AN10365 "Surface mount reflow soldering description"*.

12. Abbreviations

Table 7. Abbreviations

Acronym	Description
DDC	Display Data Channel
DVI-I	Digital Visual Interface Integrated (analog and digital)
EMI	ElectroMagnetic Interference
ESD	ElectroStatic Discharge
PLL	Phase-Locked Loop
RFI	Radio Frequency Interference
RGB	Red, Green, Blue
TTL	Transistor-Transistor Logic
VGA	Video Graphics Array

13. Revision history

Table 8. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
IP4774CZ14_1	20090224	Objective data sheet	-	-

14. Legal information

14.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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Date of release: 24 February 2009
Document identifier: IP4774CZ14_1